

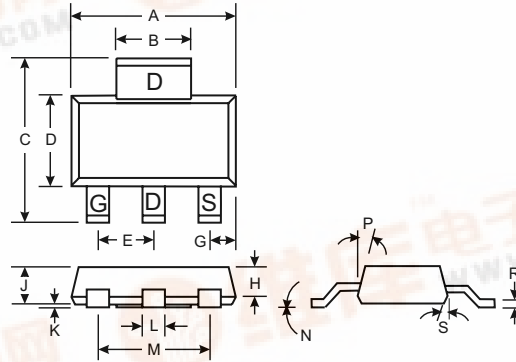


DT456P

P-CHANNEL ENHANCEMENT MODE FIELD EFFECT TRANSISTOR

Features

- High Cell Density DMOS Technology
- Low On-State Resistance
- High Power and Current Capability
- Fast Switching Speed
- High Transient Tolerance



SOT-223		
Dim	Min	Max
A	6.30	6.71
B	2.90	3.10
C	6.71	7.29
D	3.30	3.71
E	2.22	2.35
G	0.92	1.00
H	1.10	1.30
J	1.55	1.80
K	0.025	0.102
L	0.66	0.79
M	4.55	4.70
N	—	10°
P	10°	16°
R	0.254	0.356
S	10°	16°
All Dimensions in mm		

Mechanical Data

- SOT-223 Plastic Case
- Terminal Connections: See Outline Drawing and Internal Circuit Diagram Above

Maximum Ratings 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	-30	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current	I_D	± 7.5 ± 20	A
Maximum Power Dissipation	P_d	3.0 1.3 1.1	W
Operating and Storage Temperature Range	T_j, T_{STG}	-65 to +150	°C

Thermal Characteristics

Characteristic	Symbol	Value	Unit
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	42	°C/W
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	12	°C/W

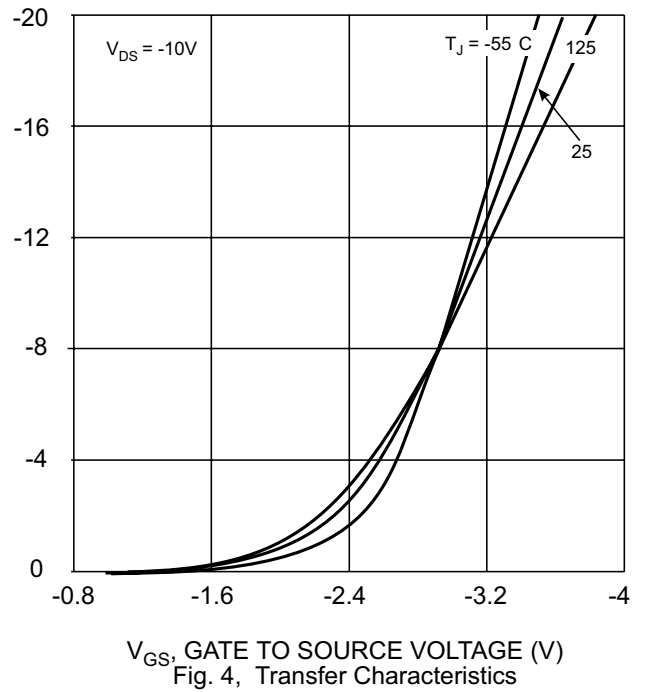
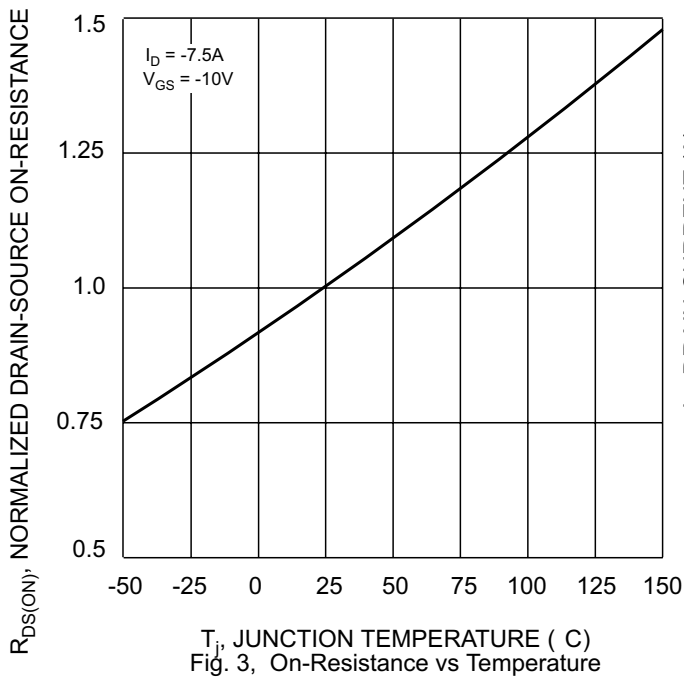
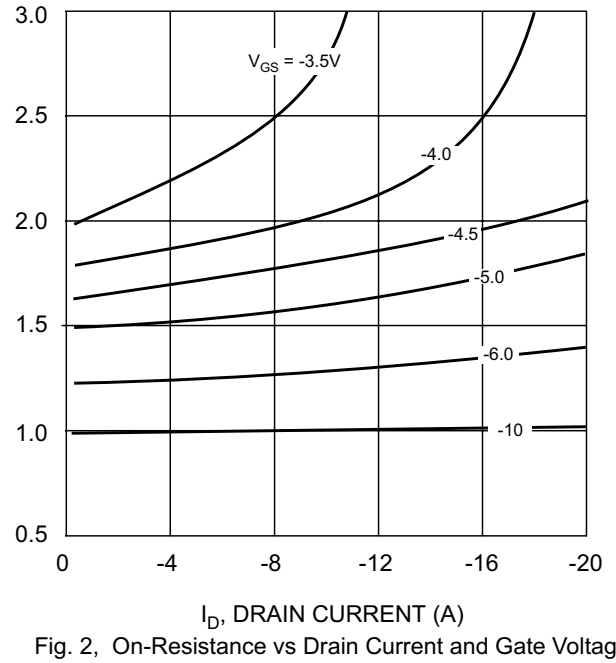
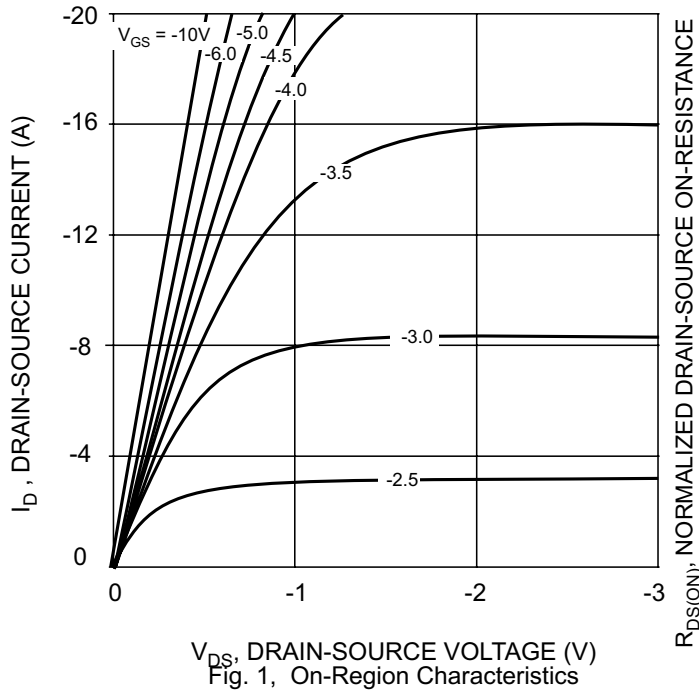
- Notes:
1. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.
 - 1a. With 1 in² oz 2 oz. copper mounting pad $R_{\theta JA} = 42^\circ\text{C/W}$.
 - 1b. With 0.0066 in² oz 2 oz. copper mounting pad $R_{\theta JA} = 95^\circ\text{C/W}$.
 - 1c. With 0.0123 in² oz 2 oz. copper mounting pad $R_{\theta JA} = 110^\circ\text{C/W}$.

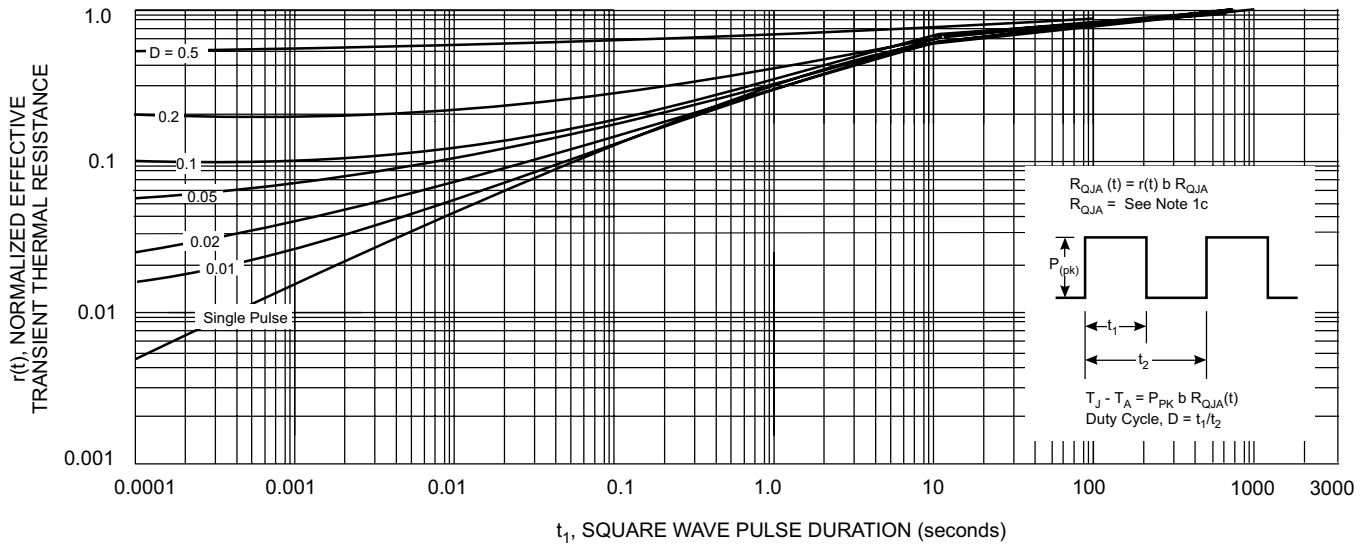
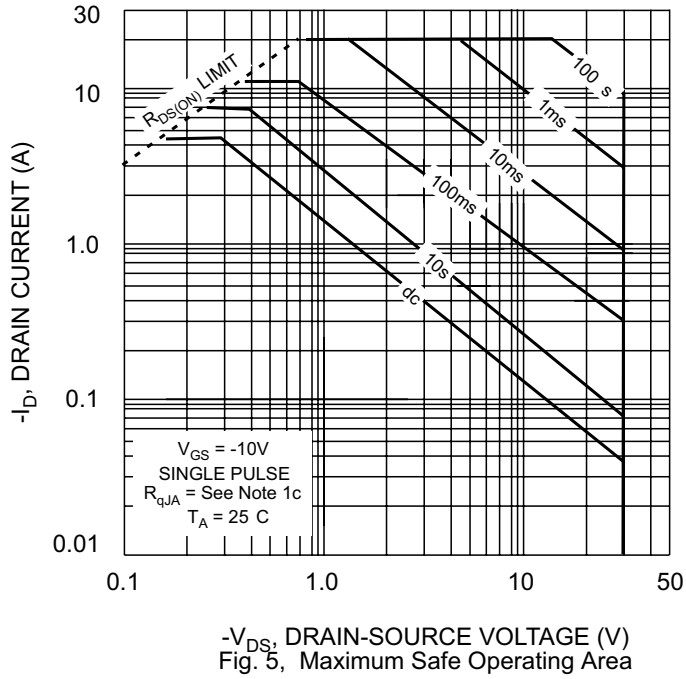


Electrical Characteristics 25°C unless otherwise specified

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	-30	—	—	V	$V_{GS} = 0V, I_D = -250\mu A$
Zero Gate Voltage Drain Current $T_j = 70^\circ C$	I_{DSS}	—	—	-1.0 -10	μA	$V_{DS} = -24V, V_{GS} = 0V$
Gate-Body Leakage, Forward	I_{GSSF}	—	—	100	nA	$V_{GS} = 20V, V_{DS} = 0V$
Gate-Body Leakage, Reverse	I_{GSSR}	—	—	-100	nA	$V_{GS} = -20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 2)						
Gate Threshold Voltage $T_j = 125^\circ C$	$V_{GS(th)}$	-1.0 -0.5	-1.5 -1.1	3.0 -2.6	V	$V_{DS} = V_{GS}, I_D = -250\mu A$
Static Drain-Source On-Resistance $T_j = 125^\circ C$	$R_{DS(ON)}$	—	0.026 0.035 0.041	0.03 0.054 0.045	Ω	$V_{GS} = -10V, I_D = -7.5A$ $V_{GS} = -10V, I_D = -7.5A$ $V_{GS} = -4.5V, I_D = -6.0A$
On-State Drain Current	$I_{D(ON)}$	-20 -10	—	—	A	$V_{GS} = -10V, V_{DS} = -5.0V$ $V_{GS} = -4.5V, V_{DS} = -5.0V$
Forward Transconductance	g_{FS}	—	13	—	m	$V_{DS} = -10V, I_D = -7.5A$
DYNAMIC CHARACTERISTICS						
Input Capacitance	C_{ISS}	—	1440	—	pF	$V_{DS} = -15V, V_{GS} = 0V$ $f = 1.0MHz$
Output Capacitance	C_{OSS}	—	905	—	pF	
Reverse Transfer Capacitance	C_{RSS}	—	355	—	pF	
SWITCHING CHARACTERISTICS (Note 2)						
Turn-On Delay Time	$t_{D(ON)}$	—	10	20	ns	$V_{DD} = -15V, I_D = -7.0A$ $V_{GEN} = -10V, R_{GEN} = 12\Omega$
Turn-On Rise Time	t_r	—	65	120	ns	
Turn-Off Delay Time	$t_{D(OFF)}$	—	70	130	ns	
Turn-Off Fall Time	t_f	—	70	130	ns	
Total Gate Charge	Q_g	—	47	67	nC	$V_{DS} = -10V, I_D = -7.5A.$ $V_{GS} = -10V$
Gate-Source Charge	Q_{gs}	—	5.0	—	nC	
Gate-Drain Charge	Q_{gd}	—	12	—	nC	
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS						
Max Continuous Drain-Source Diode Forward Current	I_S	—	—	-2.5	A	
Drain-Source Diode Forward Voltage	V_{SD}	—	-0.85	-1.2	V	$V_{GS} = 0V, I_S = -2.5A$ (Note 2)
Reverse Recovery Time	t_{rr}	—	—	140	ns	$V_{GS} = 0V, I_F = -2.5A$ $di_p/dt = 100A/\mu s$

Notes: 2. Pulse Test: Pulse width $\geq 300\mu s$, duty cycle $\leq 2.0\%$.





Remark: Thermal characterization performed under conditions described in note 1c. Transient thermal response will change depending on the circuit board design.